

KillTest

高品質 より良いサービス



練習問題

<https://www.killtest.jp>

1年間無料アップデート

Exam : TMPF

**Title : TMPF TMap Next
Foundation**

Version : Demo

1. See the definition below:

Tests in which the supplying party demonstrates that the product particularly meets the functional and non-functional specifications and the technical design, among other things.

Of which test level is this the definition?

- A. acceptance test
- B. development test
- C. system test

Answer: C

2. In which Map phase activity does the pre-test take place.?

- A. Defining central starting points
- B. Intake of the test object
- C. Specifying the test object intake
- D. Executing (re)tests

Answer: B

3. Which defect has an internal cause that can be solved within the test team?

- A. a defect in the test basis
- B. a defect in the test specification
- C. a defect in the test object

Answer: B

4. Under which circumstance can Exploratory Testing be used effectively?

- A. when experienced testers with domain knowledge are available
- B. when testing must be as brief as possible on the critical path of the project
- C. when critical functionality, failure of which can cause severe damage, must be tested

Answer: A

5. What is not an advantage of applying a test design technique and recording it in the test specifications?

- A. that the tests are reproducible
- B. that the test specifications are transferable
- C. that coverage of 100% is achieved
- D. that it provides a justified elaboration of the test strategy

Answer: C